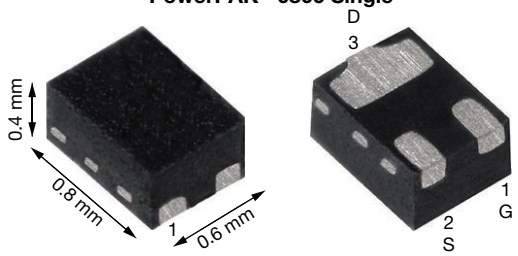
N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY			
V_{DS} (V)	$R_{DS(on)}$ (Ω) Max.	I_D (A) [a]	Q_g (Typ.)
20	0.73 at V_{GS} = 4.5 V	1	0.5 nC
	0.87 at V_{GS} = 2.5 V	0.92	
	1.10 at V_{GS} = 1.8 V	0.82	
	1.80 at V_{GS} = 1.5 V	0.64	

PowerPAK® 0806 Single



Top View | Bottom View

Marking Code: C

Ordering Information:
SiUD402ED-T1-GE3 (Lead (Pb)-free and halogen-free)

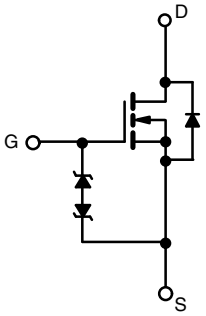
FEATURES

- TrenchFET® power MOSFET
- Ultra small 0.8 mm x 0.6 mm outline
- Ultra thin 0.4 mm max. height
- 100 % R_g tested
- Typical ESD protection 2000 V (HBM)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

Pb-free
RoHS COMPLIANT
HALOGEN FREE

APPLICATIONS

- Load switch
- High speed switching
- DC/DC converters
- For smart phones, tablet PCs and mobile computing
- Small signal switching



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C, unless otherwise noted)				
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	20	V
Gate-Source Voltage		V_{GS}	± 8	
Continuous Drain Current (T_J = 150 °C)	T_A = 25 °C	I_D	1 [a]	A
	T_A = 70 °C		0.8 [a]	
	T_A = 25 °C		0.35 [b]	
	T_A = 70 °C		0.28 [b]	
Pulsed Drain Current (t = 100 µs)		I_{DM}	1.4	
Continuous Source-Drain Diode Current	T_A = 25 °C	I_S	1 [a]	
	T_A = 25 °C		0.37 [b]	
Maximum Power Dissipation	T_A = 25 °C	P_D	1.25 [a]	W
	T_A = 70 °C		0.8 [a]	
	T_A = 25 °C		0.37 [b]	
	T_A = 70 °C		0.24 [b]	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-55 to +150	°C
Soldering Recommendations (Peak Temperature) [c]			260	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient [a, d]	t ≤ 5 s	R_{thJA}	80	100	°C/W
Maximum Junction-to-Ambient [b, e]			265	335	

Notes

a. Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s.
b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 5 s.
c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
d. Maximum under steady state conditions is 135 °C/W.
e. Maximum under steady state conditions is 400 °C/W.

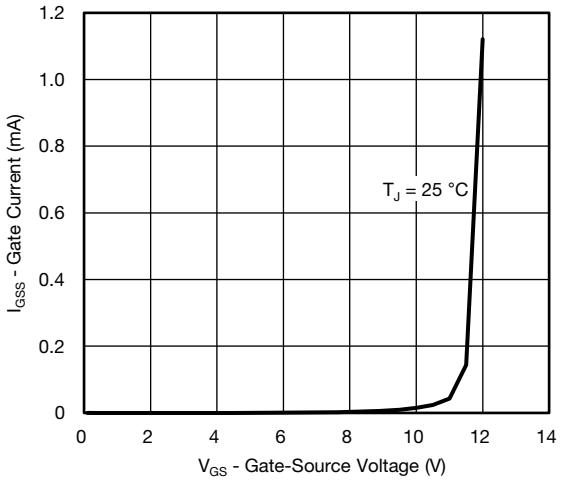
SPECIFICATIONS (T_J = 25 °C, unless otherwise noted)						
Parameter	**Symbol**	**Test Conditions**	**Min.**	**Typ.**	**Max.**	**Unit**
Static						
Drain-Source Breakdown Voltage	V_{DS}	V_{GS} = 0 V, I_D = 250 µA	20	-	-	V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	I_D = 250 µA	-	18	-	mV/°C
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$		-	-1.9	-	
Gate-Source Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS} , I_D = 250 µA	0.4	-	0.9	V
Gate-Source Leakage	I_{GSS}	V_{DS} = 0 V, V_{GS} = ± 4.5 V	-	-	± 0.5	µA
		V_{DS} = 0 V, V_{GS} = ± 8 V	-	-	± 10	
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 20 V, V_{GS} = 0 V	-	-	1	
		V_{DS} = 20 V, V_{GS} = 0 V, T_J = 55 °C	-	-	10	
On-State Drain Current [a]	$I_{D(on)}$	V_{DS} ≥ 5 V, V_{GS} = 4.5 V	1	-	-	A
Drain-Source On-State Resistance [a]	$R_{DS(on)}$	V_{GS} = 4.5 V, I_D = 0.2 A	-	0.57	0.73	Ω
		V_{GS} = 2.5 V, I_D = 0.1 A	-	0.67	0.87	
		V_{GS} = 1.8 V, I_D = 0.02 A	-	0.80	1.10	
		V_{GS} = 1.5 V, I_D = 0.01 A	-	0.90	1.80	
Forward Transconductance [a]	g_{fs}	V_{DS} = 10 V, I_D = 0.2 A	-	1.2	-	S
Dynamic [b]						
Input Capacitance	C_{iss}	V_{DS} = 10 V, V_{GS} = 0 V, f = 1 MHz	-	16	-	pF
Output Capacitance	C_{oss}		-	7.5	-	
Reverse Transfer Capacitance	C_{rss}		-	3.5	-	
Total Gate Charge	Q_g	V_{DS} = 10 V, V_{GS} = 8 V, I_D = 0.2 A	-	0.75	1.20	nC
		V_{DS} = 10 V, V_{GS} = 4.5 V, I_D = 0.2 A	-	0.50	0.75	
Gate-Source Charge	Q_{gs}		-	0.09	-	
Gate-Drain Charge	Q_{gd}		-	0.09	-	
Gate Resistance	R_g	f = 1 MHz	3	24	50	Ω
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 10 V, R_L = 50 Ω I_D ≅ 0.2 A, V_{GEN} = 4.5 V, Rg = 1 Ω	-	7	15	ns
Rise Time	t_r		-	10	20	
Turn-Off Delay Time	$t_{d(off)}$		-	23	50	
Fall Time	t_f		-	7	15	
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 10 V, R_L = 15 Ω I_D ≅ 0.2 A, V_{GEN} = 8 V, R_g = 1 Ω	-	5	10	
Rise Time	t_r		-	5	10	
Turn-Off Delay Time	$t_{d(off)}$		-	11	25	
Fall Time	t_f		-	5	10	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	T_C = 25 °C	-	-	1 [c]	A
Pulse Diode Forward Current	I_{SM}		-	-	1.4	
Body Diode Voltage	V_{SD}	I_S = 0.2 A, V_{GS} = 0 V	-	0.8	1.2	V
Body Diode Reverse Recovery Time	t_{rr}	I_F = 0.2 A, dI/dt = 100 A/µs, T_J = 25 °C	-	11	25	ns
Body Diode Reverse Recovery Charge	Q_{rr}		-	3.5	7	nC
Reverse Recovery Fall Time	t_a		-	5.3	-	ns
Reverse Recovery Rise Time	t_b		-	5.7	-	

Note

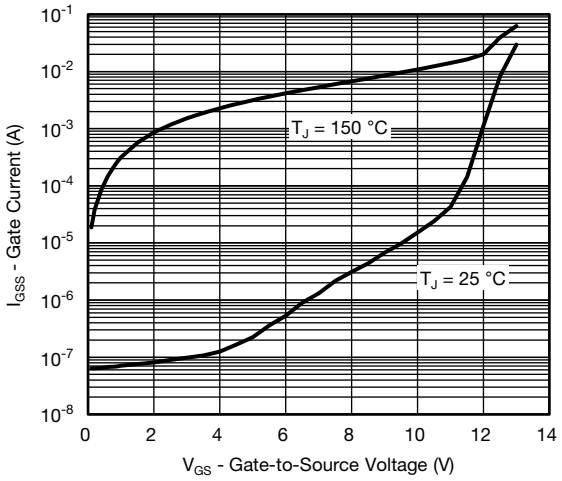
a. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.
b. Guaranteed by design, not subject to production testing.
c. Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

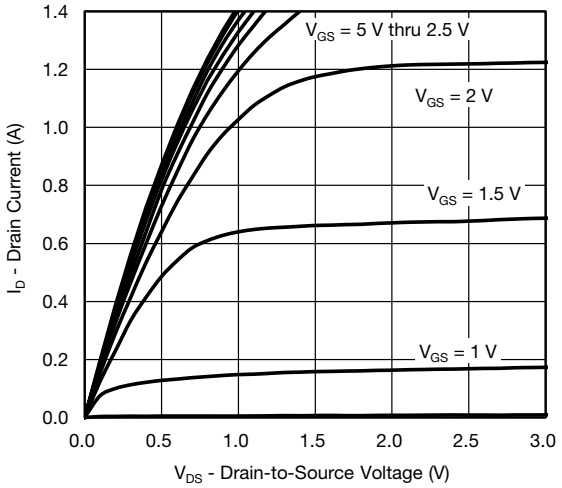
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted



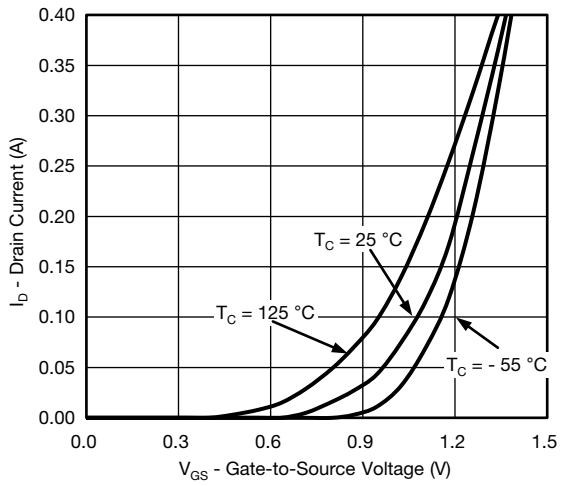
Gate Current vs. Gate-Source Voltage



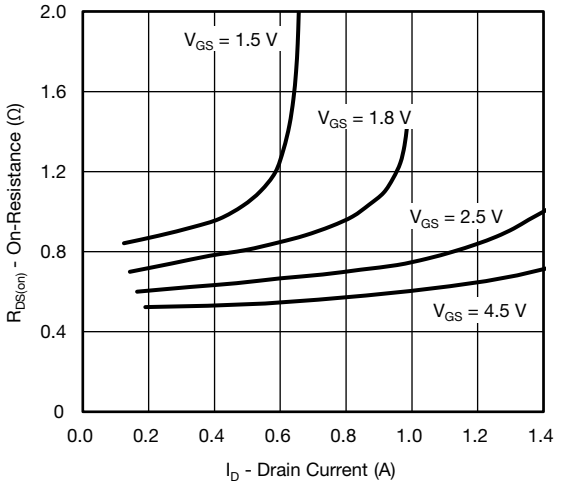
Gate Current vs. Gate-Source Voltage



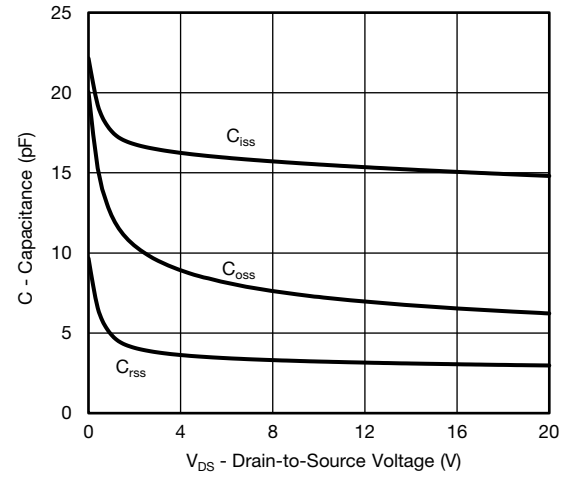
Output Characteristics



Transfer Characteristics

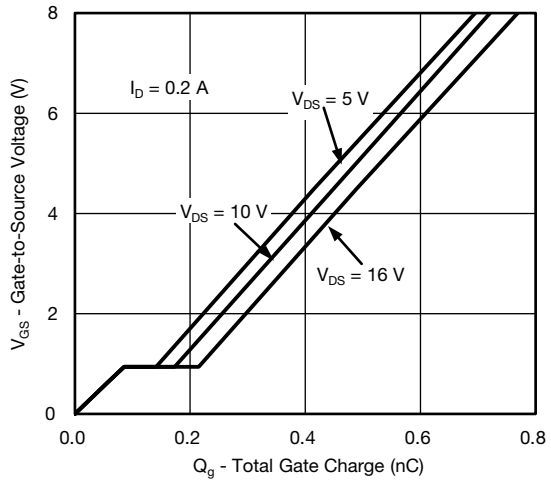


On-Resistance vs. Drain Current

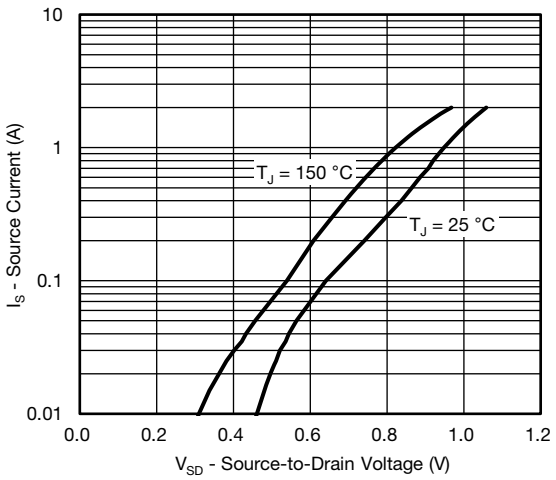


Capacitance vs. Drain-to-Source Voltage

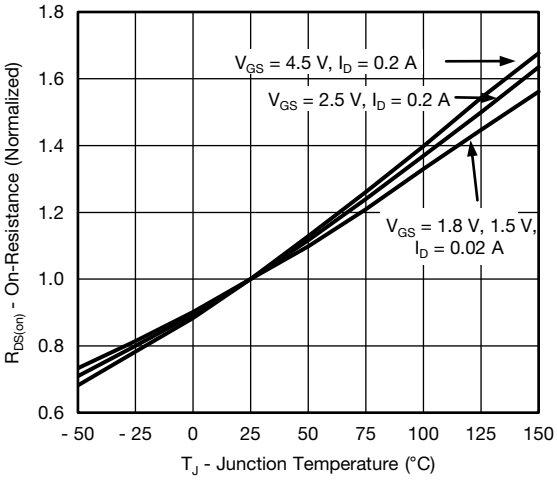
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



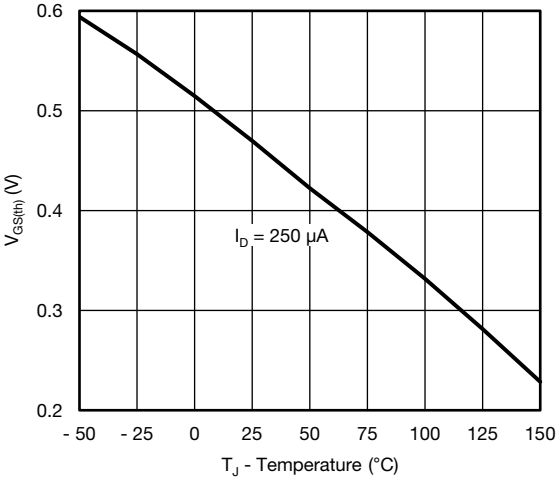
Gate Charge



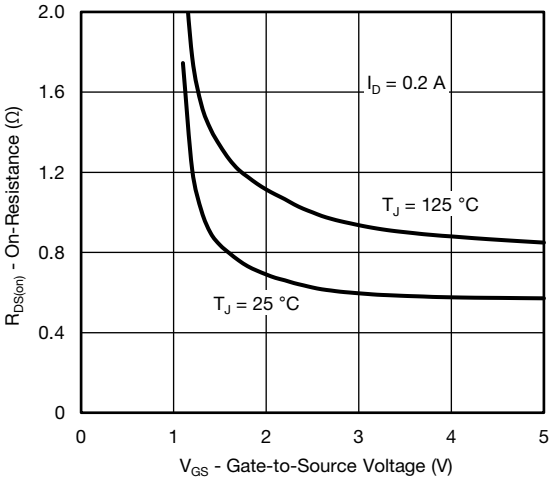
Source-Drain Diode Forward Voltage



On-Resistance vs. Junction Temperature

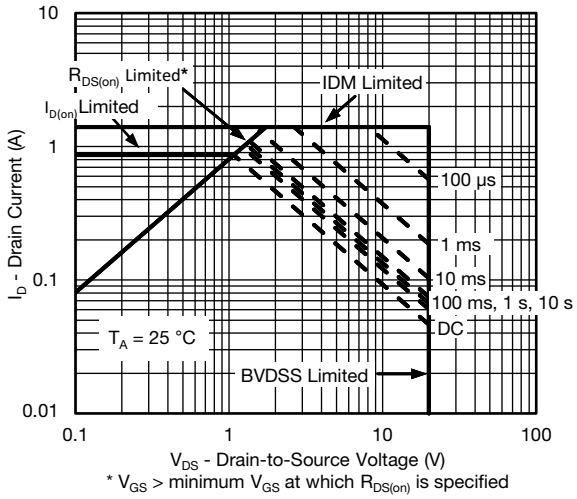


Threshold Voltage

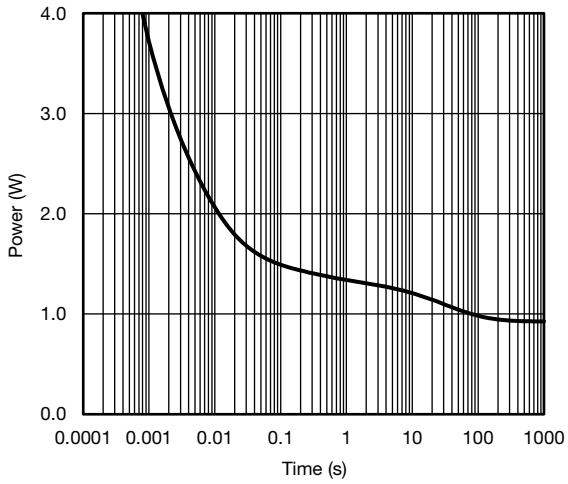


On-Resistance vs. Gate-to-Source Voltage

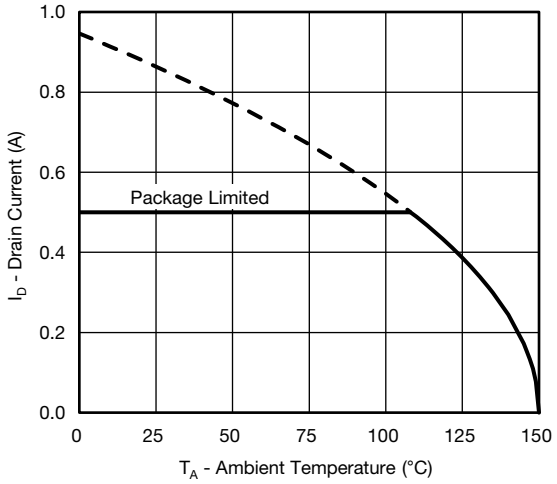
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



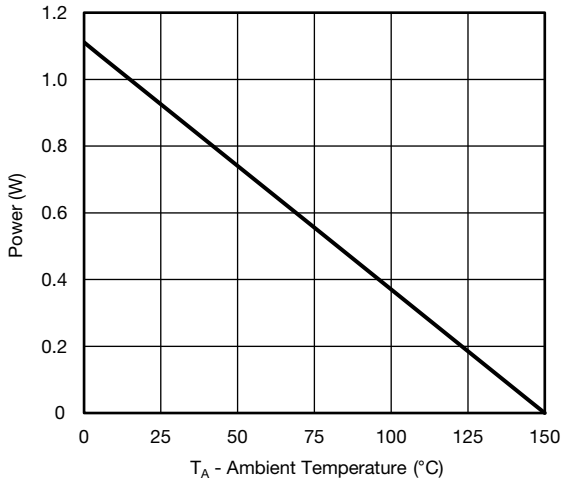
Safe Operating Area (Junction-to-Ambient) [a]



Single Pulse Power, Junction-to-Ambient [a]



Current Derating [a, b]



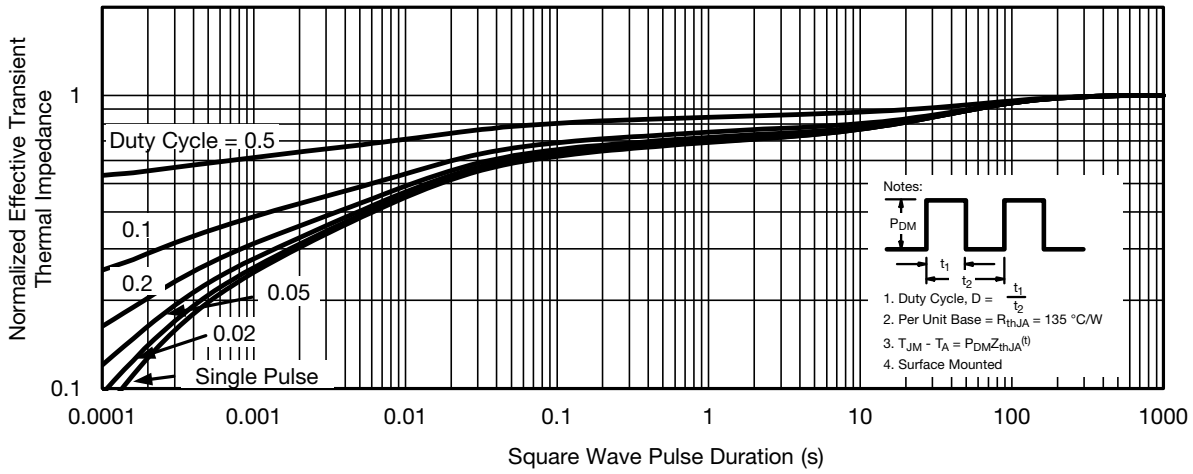
Power Derating [a]

Note

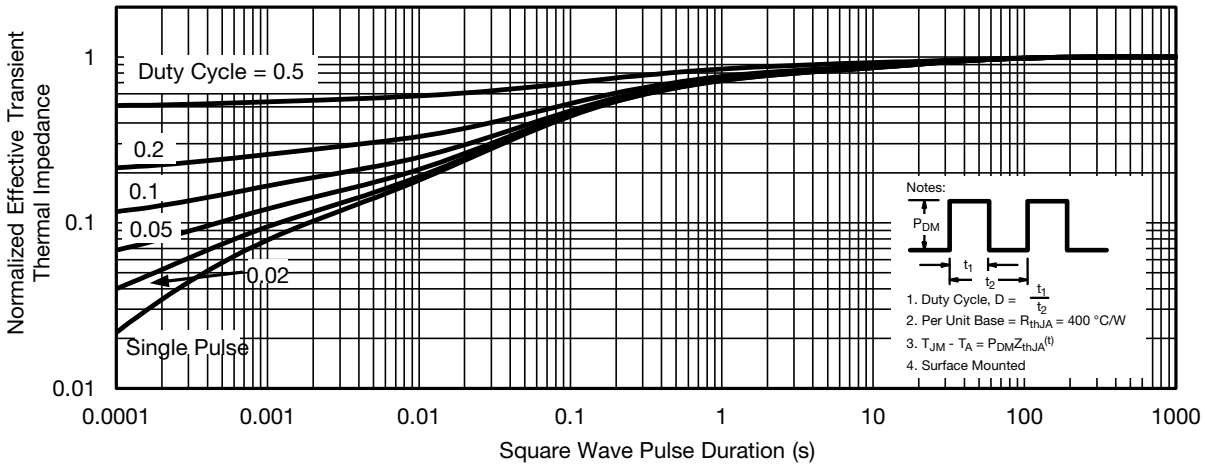
a. When mounted on 1" x 1" FR4 with full copper.

b. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-ambient thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



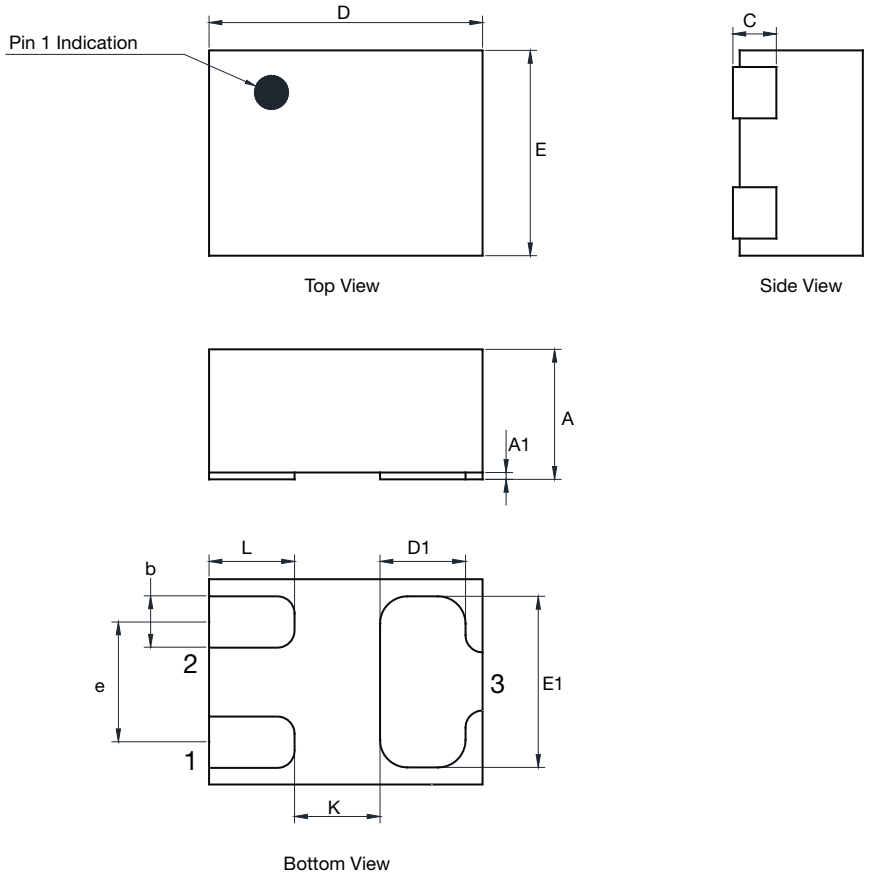
Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 board with maximum copper)



Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 board with minimum copper)

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?62968.

Case Outline for PowerPAK 0.8 mm x 0.6 mm



DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.350	0.380	0.400	0.0138	0.0150	0.0157
A1	0	-	0.020	0	-	0.0008
b	0.120	0.150	0.180	0.0047	0.0059	0.0071
C	0.119	0.127	0.135	0.0047	0.0050	0.0053
D	0.750	0.800	0.850	0.0295	0.0315	0.0335
D1	0.200	0.250	0.300	0.0078	0.0098	0.0118
E	0.550	0.600	0.650	0.0217	0.0236	0.0256
E1	0.450	0.500	0.550	0.0177	0.0197	0.0217
e	0.300	0.350	0.400	0.0118	0.0138	0.0158
K	0.150	0.250	0.350	0.0058	0.0098	0.0138
L	0.200	0.250	0.300	0.0078	0.0098	0.0118
ECN: C13-1574-Rev. A, 23-Dec-13 DWG: 6020						

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, “Vishay”), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay’s knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer’s responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer’s technical experts. Product specifications do not expand or otherwise modify Vishay’s terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.